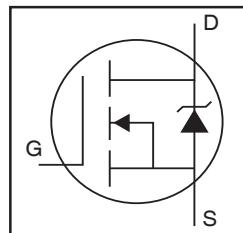


Features

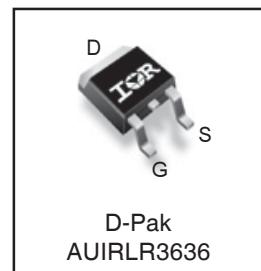
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to T_{jmax}
- Lead-Free, RoHS Compliant
- Automotive Qualified *

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.



V_{DSS}	60V
$R_{DS(on)}$ typ. max.	5.4mΩ 6.8mΩ
I_D (Silicon Limited)	99A①
I_D (Package Limited)	50A



G	D	S
Gate	Drain	Source

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T_A) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I_D @ $T_C = 25^\circ\text{C}$	Continuous Drain Current, V_{GS} @ 10V (Silicon Limited)	99 ①	A
I_D @ $T_C = 100^\circ\text{C}$	Continuous Drain Current, V_{GS} @ 10V (Silicon Limited)	70 ①	
I_D @ $T_C = 25^\circ\text{C}$	Continuous Drain Current, V_{GS} @ 10V (Package Limited)	50	
I_{DM}	Pulsed Drain Current ②	396	
P_D @ $T_C = 25^\circ\text{C}$	Maximum Power Dissipation	143	W
	Linear Derating Factor	0.95	W/°C
V_{GS}	Gate-to-Source Voltage	±16	V
E_{AS}	Single Pulse Avalanche Energy (Thermally Limited) ③	170	mJ
I_{AR}	Avalanche Current ②	See Fig.14, 15, 22a, 22b	A
E_{AR}	Repetitive Avalanche Energy ②		mJ
dv/dt	Peak Diode Recovery ④	22	V/ns
T_J	Operating Junction and	-55 to + 175	°C
T_{STG}	Storage Temperature Range		
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ⑤	—	1.05	°C/W
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount) ⑥	—	50	
$R_{\theta JA}$	Junction-to-Ambient	—	110	

HEXFET® is a registered trademark of International Rectifier.

*Qualification standards can be found at <http://www.irf.com/>

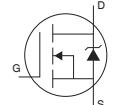
Static Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	60	—	—	V	$V_{\text{GS}} = 0\text{V}$, $I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.07	—	V/ $^\circ\text{C}$	Reference to 25°C , $I_D = 5\text{mA}$ ②
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	5.4	6.8	$\text{m}\Omega$	$V_{\text{GS}} = 10\text{V}$, $I_D = 50\text{A}$ ⑤
		—	6.6	8.3		$V_{\text{GS}} = 4.5\text{V}$, $I_D = 50\text{A}$ ⑤
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	1.0	—	2.5	V	$V_{\text{DS}} = V_{\text{GS}}$, $I_D = 100\mu\text{A}$
g_{fs}	Forward Transconductance	31	—	—	S	$V_{\text{DS}} = 25\text{V}$, $I_D = 50\text{A}$
$R_{\text{G}(\text{int})}$	Internal Gate Resistance	—	0.6	—	Ω	
I_{DSS}	Drain-to-Source Leakage Current	—	—	20	μA	$V_{\text{DS}} = 60\text{V}$, $V_{\text{GS}} = 0\text{V}$
		—	—	250		$V_{\text{DS}} = 60\text{V}$, $V_{\text{GS}} = 0\text{V}$, $T_J = 125^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{\text{GS}} = 16\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{\text{GS}} = -16\text{V}$

Dynamic Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
Q_g	Total Gate Charge	—	33	49	nC	$I_D = 50\text{A}$
Q_{gs}	Gate-to-Source Charge	—	11	—		$V_{\text{DS}} = 30\text{V}$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	15	—		$V_{\text{GS}} = 4.5\text{V}$ ⑤
Q_{sync}	Total Gate Charge Sync. ($Q_g - Q_{\text{gd}}$)	—	18	—		$I_D = 50\text{A}$, $V_{\text{DS}} = 0\text{V}$, $V_{\text{GS}} = 4.5\text{V}$
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	45	—	ns	$V_{\text{DD}} = 39\text{V}$
t_r	Rise Time	—	216	—		$I_D = 50\text{A}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	43	—		$R_G = 7.5\Omega$
t_f	Fall Time	—	69	—		$V_{\text{GS}} = 4.5\text{V}$ ⑤
C_{iss}	Input Capacitance	—	3779	—	pF	$V_{\text{GS}} = 0\text{V}$
C_{oss}	Output Capacitance	—	332	—		$V_{\text{DS}} = 50\text{V}$
C_{rss}	Reverse Transfer Capacitance	—	163	—		$f = 1.0\text{MHz}$
C_{oss} eff. (ER)	Effective Output Capacitance (Energy Related) ⑦	—	437	—		$V_{\text{GS}} = 0\text{V}$, $V_{\text{DS}} = 0\text{V}$ to 48V ⑦, See Fig.11
C_{oss} eff. (TR)	Effective Output Capacitance (Time Related) ⑥	—	636	—		$V_{\text{GS}} = 0\text{V}$, $V_{\text{DS}} = 0\text{V}$ to 48V ⑥

Diode Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
I_s	Continuous Source Current (Body Diode)	—	—	99 ①	A	MOSFET symbol showing the integral reverse p-n junction diode.
	Pulsed Source Current (Body Diode) ②	—	—	396		
V_{SD}	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}$, $I_s = 50\text{A}$, $V_{\text{GS}} = 0\text{V}$ ⑤
	Reverse Recovery Time	—	27	—		$T_J = 25^\circ\text{C}$ $V_R = 51\text{V}$,
Q_{rr}	Reverse Recovery Charge	—	32	—	ns	$T_J = 125^\circ\text{C}$ $I_F = 50\text{A}$
		—	31	—		$T_J = 25^\circ\text{C}$ $\text{di}/\text{dt} = 100\text{A}/\mu\text{s}$ ⑤
		—	43	—	nC	$T_J = 125^\circ\text{C}$
I_{RRM}	Reverse Recovery Current	—	2.1	—		$T_J = 25^\circ\text{C}$
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

Notes:

- ① Calculated continuous current based on maximum allowable junction temperature Bond wire current limit is 50A. Note that current limitation arising from heating of the device leads may occur with some lead mounting arrangements.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- ③ Limited by T_{Jmax} , starting $T_J = 25^\circ\text{C}$, $L = 0.136\text{ mH}$ $R_G = 25\Omega$, $I_{\text{AS}} = 50\text{A}$, $V_{\text{GS}} = 10\text{V}$. Part not recommended for use above this value .
- ④ $I_{\text{SD}} \leq 50\text{A}$, $\text{di}/\text{dt} \leq 1109\text{ A}/\mu\text{s}$, $V_{\text{DD}} \leq V_{(\text{BR})\text{DSS}}$, $T_J \leq 175^\circ\text{C}$.

⑤ Pulse width $\leq 400\mu\text{s}$; duty cycle $\leq 2\%$.

⑥ C_{oss} eff. (TR) is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .

⑦ C_{oss} eff. (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .

⑧ When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniquea refer to appocation note # AN- 994 techniques refer to application note #AN-994.

⑨ R_{θ} is measured at T_J approximately 90°C .

Qualification Information[†]

Qualification Level	Automotive (per AEC-Q101) ^{††}	
	Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.	
Moisture Sensitivity Level	D-PAK	MSL1
ESD	Machine Model	Class M4 (+/- 600V) ^{†††} AEC-Q101-002
	Human Body Model	Class H1C (+/- 2000V) ^{†††} AEC-Q101-001
	Charged Device Model	Class C5 (+/- 2000V) ^{†††} AEC-Q101-005
RoHS Compliant	Yes	

[†] Qualification standards can be found at International Rectifier's web site: <http://www.irf.com/>

^{††} Exceptions (if any) to AEC-Q101 requirements are noted in the qualification report.

^{†††} Highest passing voltage.

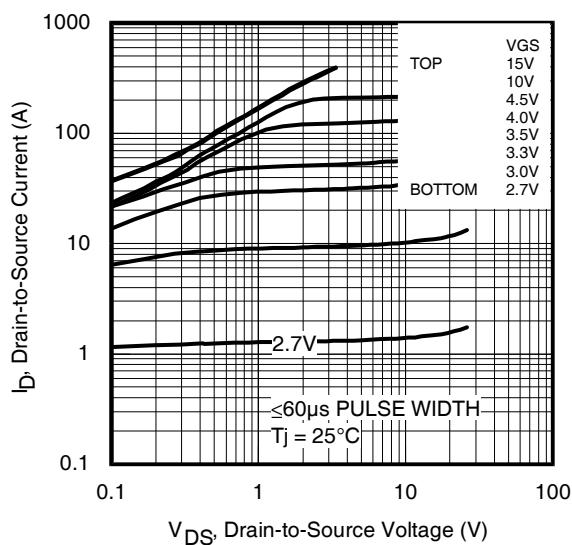


Fig 1. Typical Output Characteristics

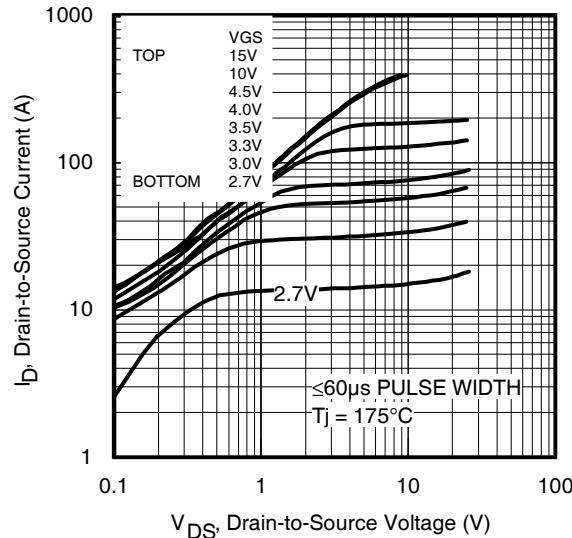


Fig 2. Typical Output Characteristics

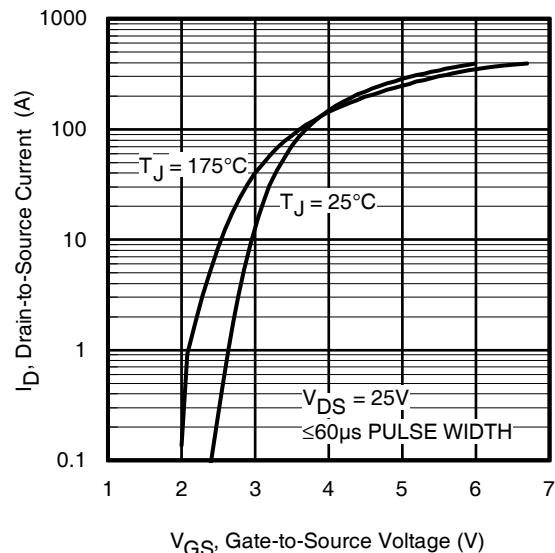


Fig 3. Typical Transfer Characteristics

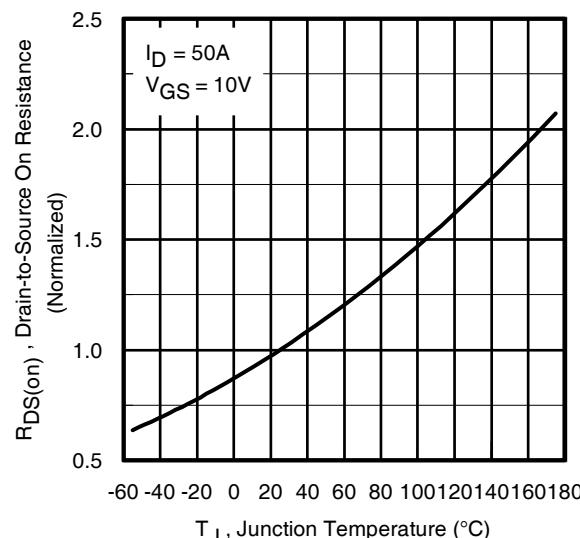


Fig 4. Normalized On-Resistance vs. Temperature

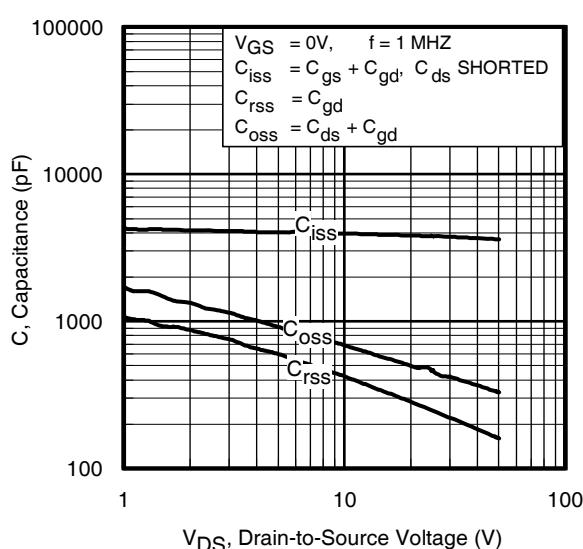


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

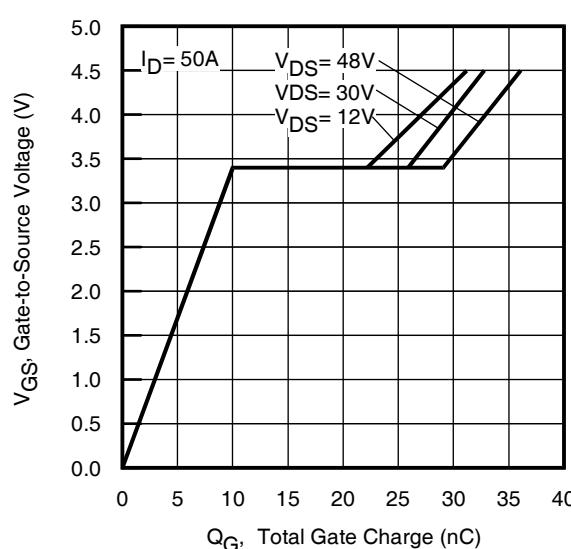


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

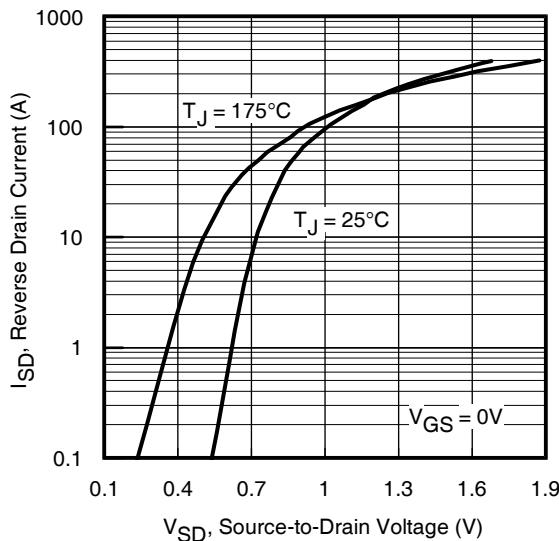


Fig 7. Typical Source-Drain Diode Forward Voltage

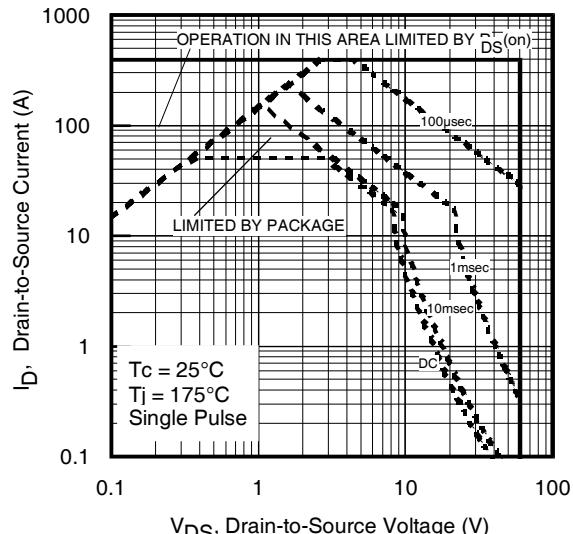


Fig 8. Maximum Safe Operating Area

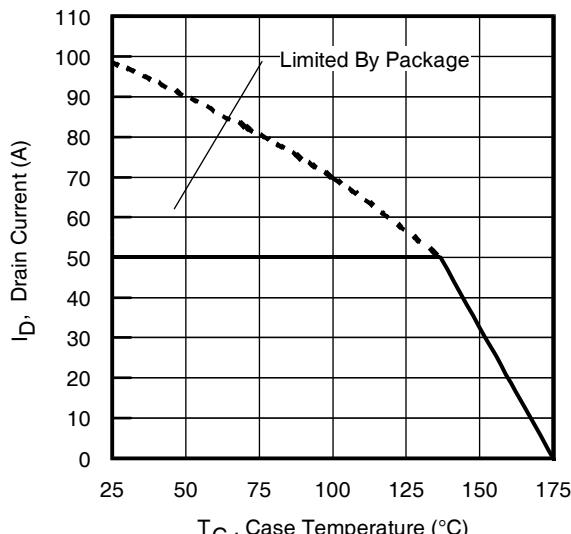


Fig 9. Maximum Drain Current vs. Case Temperature

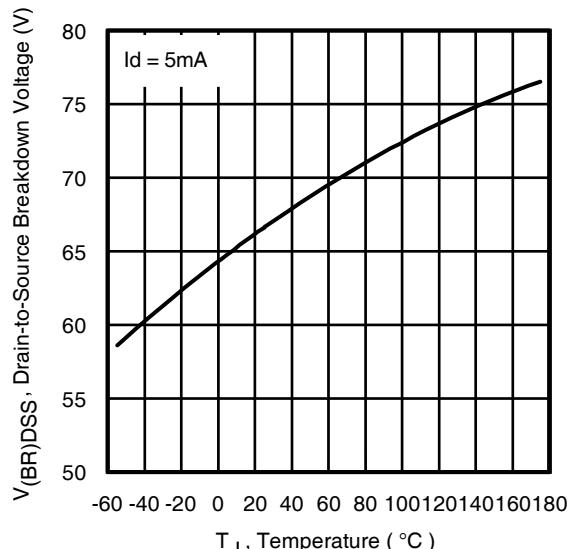


Fig 10. Drain-to-Source Breakdown Voltage

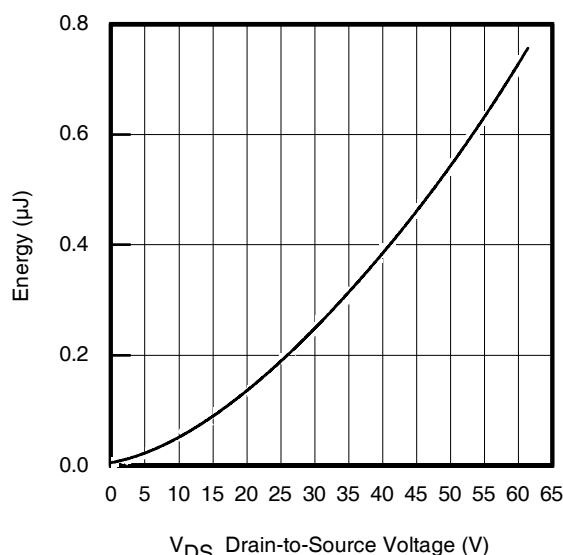


Fig 11. Typical Coss Stored Energy

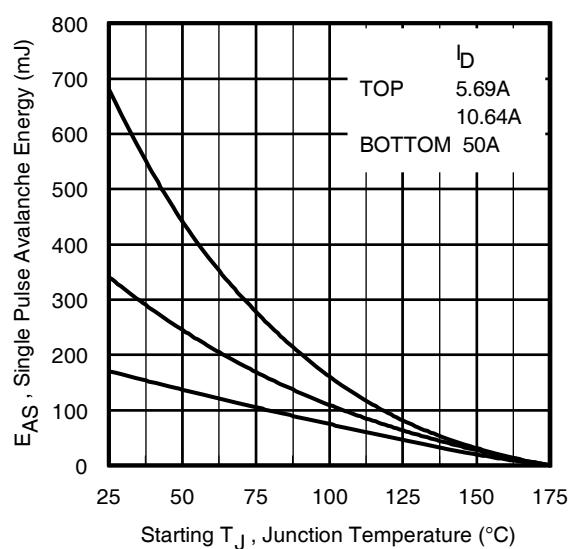


Fig 12. Maximum Avalanche Energy vs. Drain Current

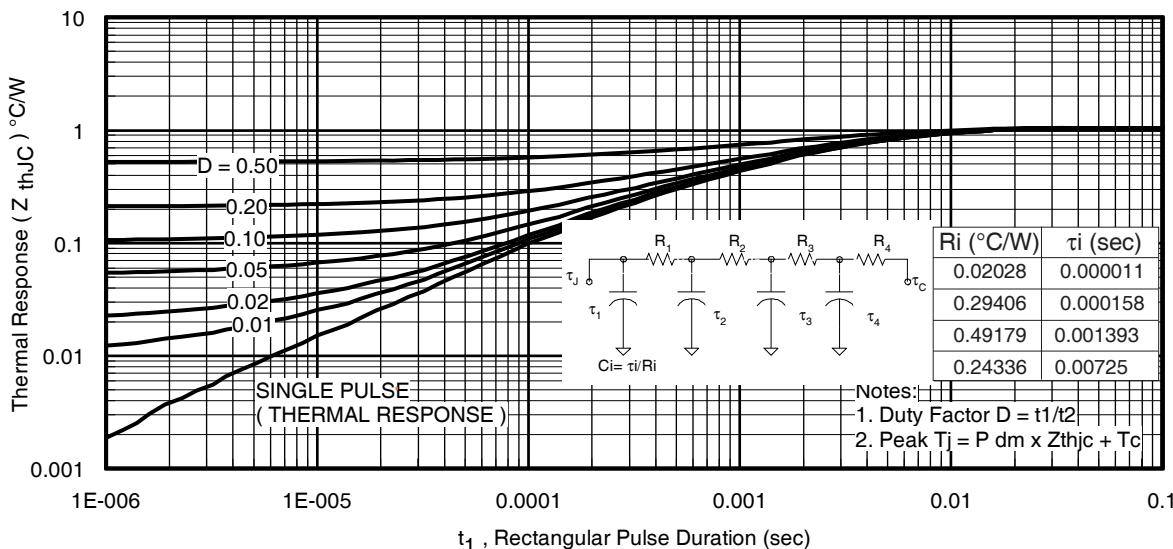


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

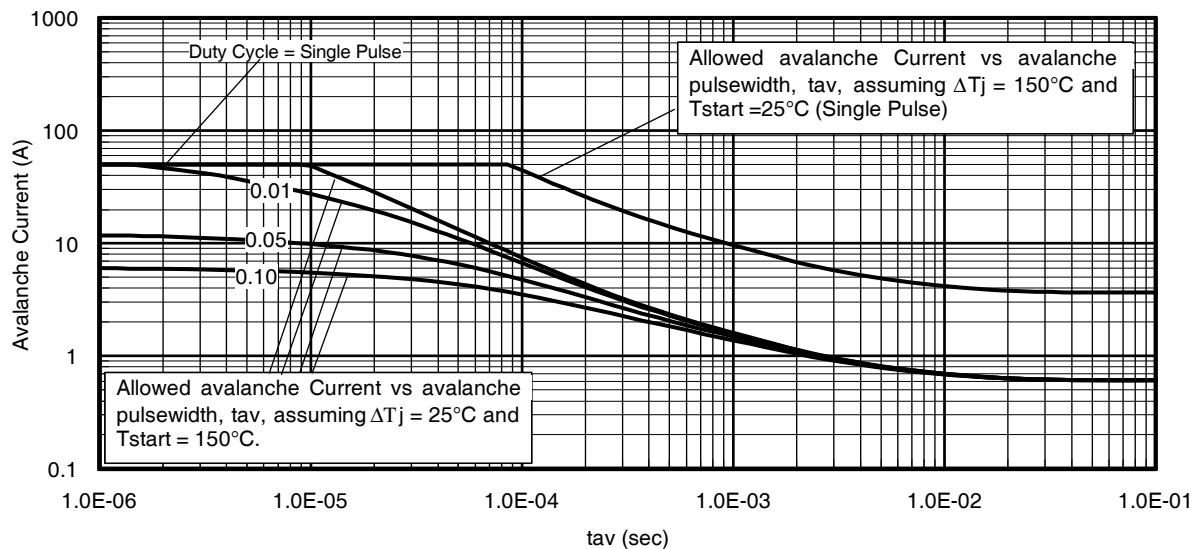
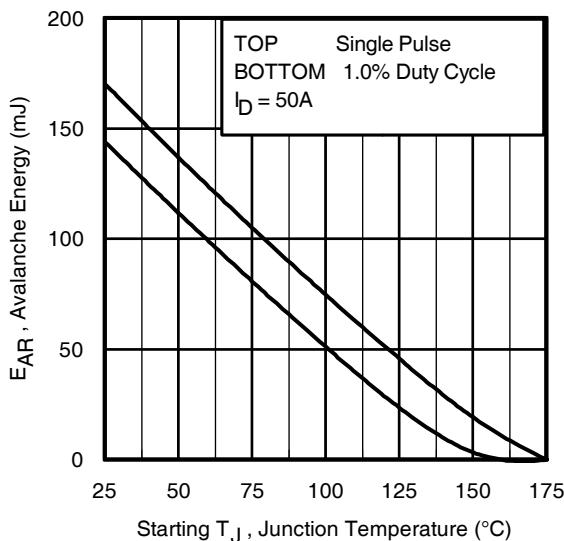


Fig 14. Typical Avalanche Current vs. Pulsewidth



Notes on Repetitive Avalanche Curves , Figures 14, 15:
(For further info, see AN-1005 at www.irf.com)

1. Avalanche failures assumption:
Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax} . This is validated for every part type.
2. Safe operation in Avalanche is allowed as long as T_{jmax} is not exceeded.
3. Equation below based on circuit and waveforms shown in Figures 16a, 16b.
4. $P_{D(ave)}$ = Average power dissipation per single avalanche pulse.
5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
6. I_{av} = Allowable avalanche current.
7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 14, 15).

t_{av} = Average time in avalanche.

D = Duty cycle in avalanche = $t_{av} \cdot f$

$Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see Figures 13

$$P_{D(ave)} = 1/2 (1.3 \cdot BV \cdot I_{av}) = \Delta T / Z_{thJC}$$

$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$

$$E_{AS(AR)} = P_{D(ave)} \cdot t_{av}$$

Fig 15. Maximum Avalanche Energy vs. Temperature

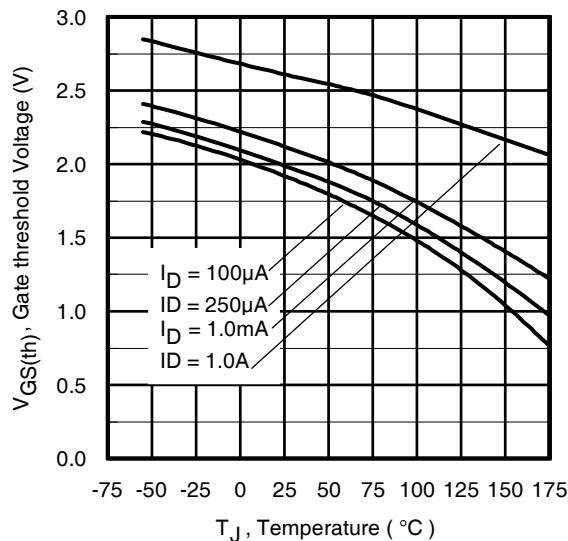


Fig. 16. Threshold Voltage vs. Temperature

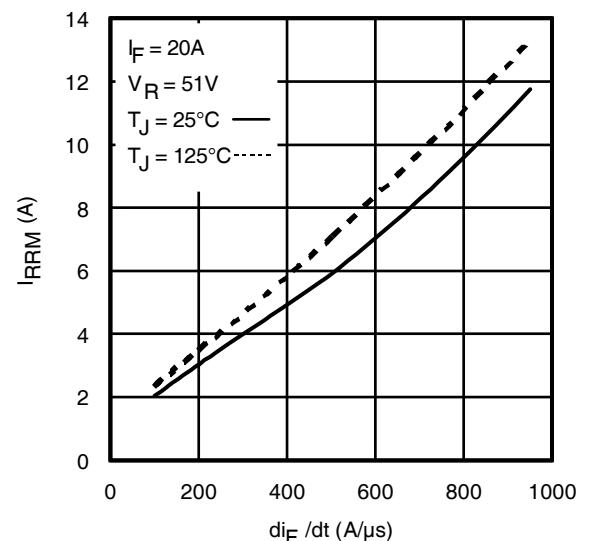


Fig. 17 - Typical Recovery Current vs. di_F/dt

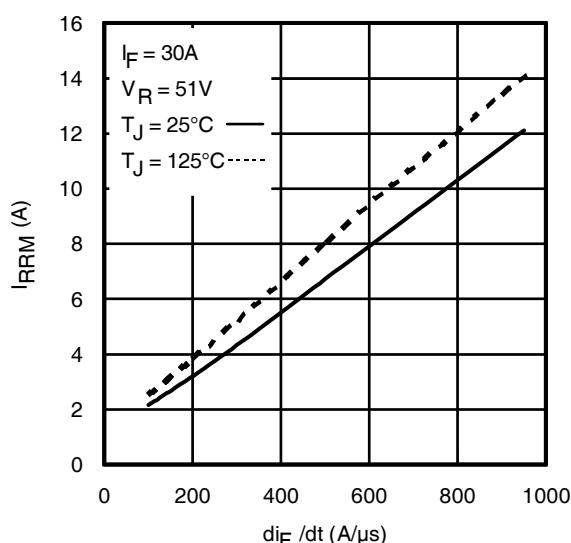


Fig. 18 - Typical Recovery Current vs. di_F/dt

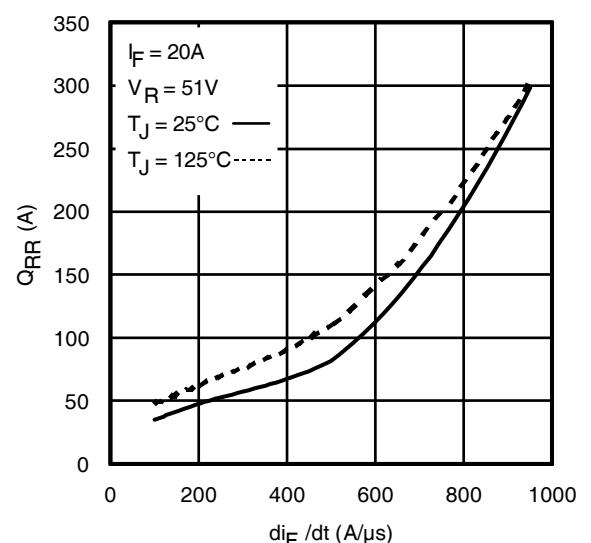


Fig. 19 - Typical Stored Charge vs. di_F/dt

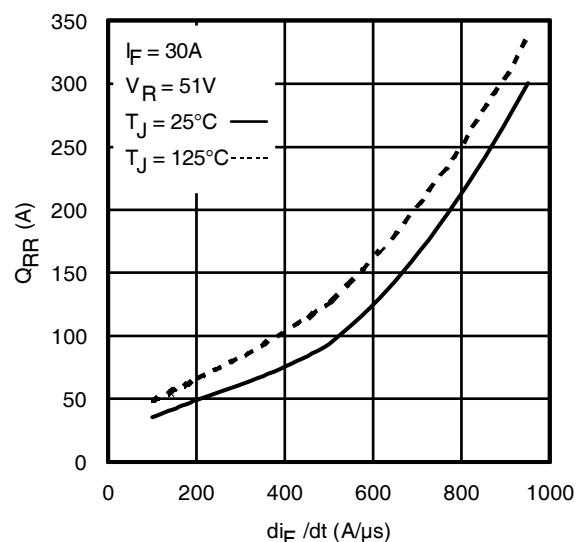


Fig. 20 - Typical Stored Charge vs. di_F/dt

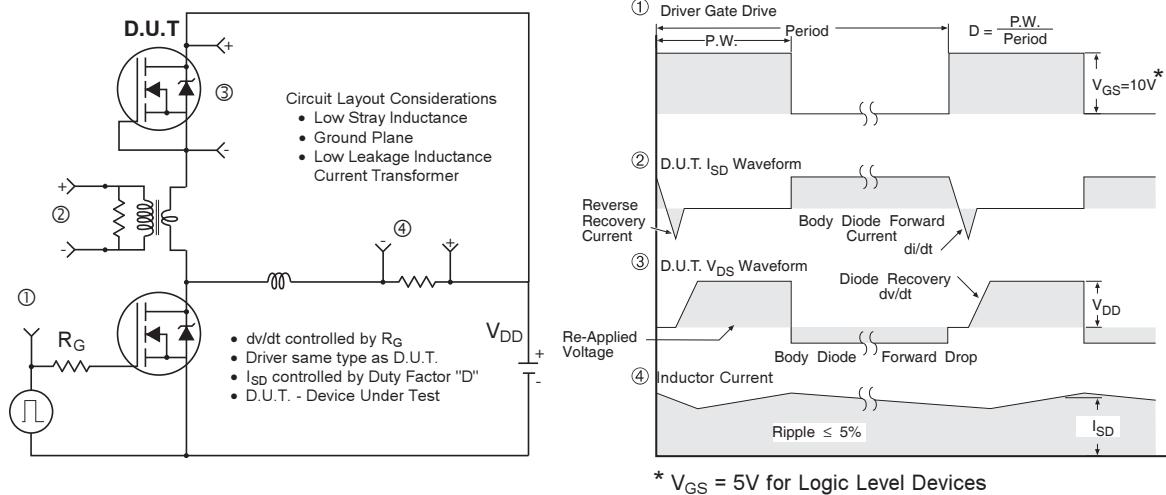


Fig 21. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

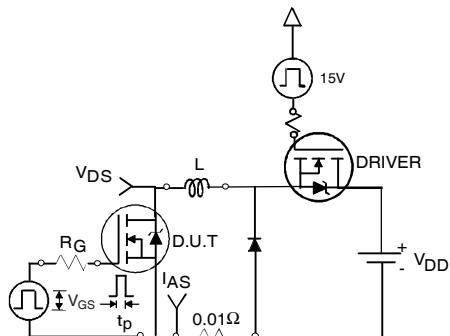


Fig 22a. Unclamped Inductive Test Circuit

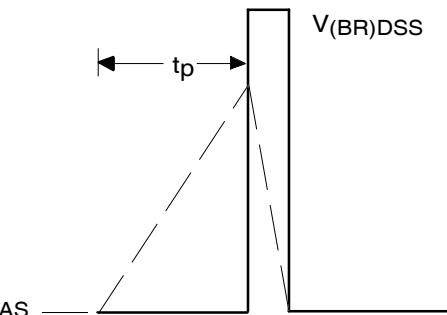


Fig 22b. Unclamped Inductive Waveforms

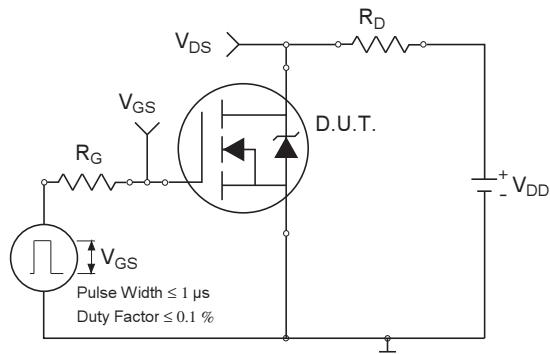


Fig 23a. Switching Time Test Circuit

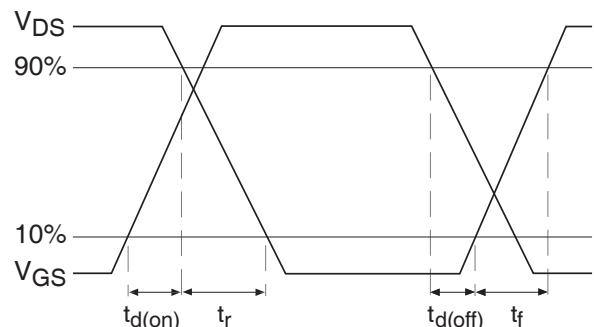


Fig 23b. Switching Time Waveforms

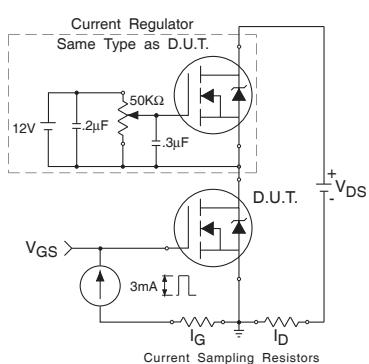


Fig 24a. Gate Charge Test Circuit

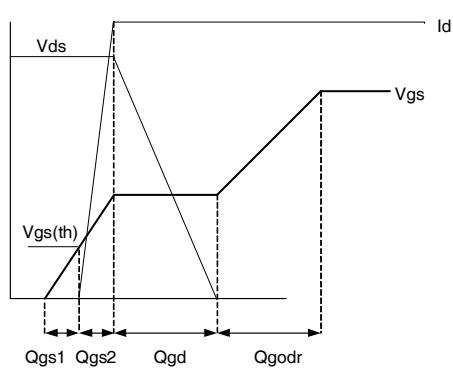
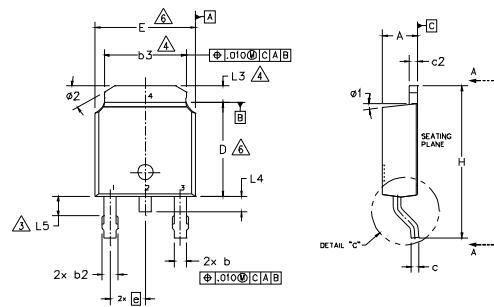


Fig 24b. Gate Charge Waveform

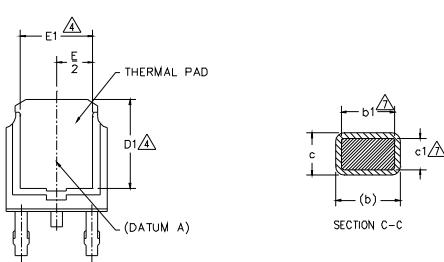
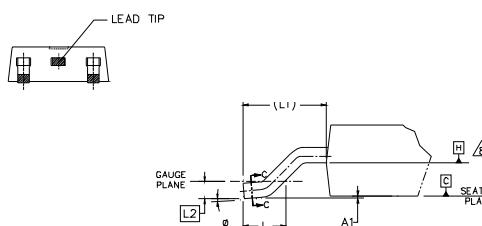
D-Pak (TO-252AA) Package Outline

Dimensions are shown in millimeters (inches)



NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- 3.- LEAD DIMENSION UNCONTROLLED IN L5.
- 4.- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- 6.- DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- 7.- DIMENSION b1 & c1 APPLIED TO BASE METAL ONLY.
- 8.- DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.



VIEW A-A

S Y M B O L	DIMENSIONS		N O T E S	
	MILLIMETERS			
	MIN.	MAX.		
A	2.18	2.39	.086 .094	
A1	—	0.13	— .005	
b	0.64	0.89	.025 .035	
b1	0.65	0.79	.025 .031	
b2	0.76	1.14	.030 .045	
b3	4.95	5.46	.195 .215	
c	0.46	0.61	.018 .024	
c1	0.41	0.56	.016 .022	
c2	0.46	0.89	.018 .035	
D	5.97	6.22	.235 .245	
D1	5.21	—	.205 —	
E	6.35	6.73	.250 .265	
E1	4.32	—	.170 —	
e	2.29 BSC	—	.090 BSC	
H	9.40	10.41	.370 .410	
L	1.40	1.78	.055 .070	
L1	2.74 BSC	—	.108 REF.	
L2	0.51 BSC	—	.020 BSC	
L3	0.89	1.27	.035 .050	
L4	—	1.02	— .040	
L5	1.14	1.52	.045 .060	
Ø	0°	10°	0° 10°	
Ø1	0°	15°	0° 15°	
Ø2	25°	35°	25° 35°	

LEAD ASSIGNMENTS

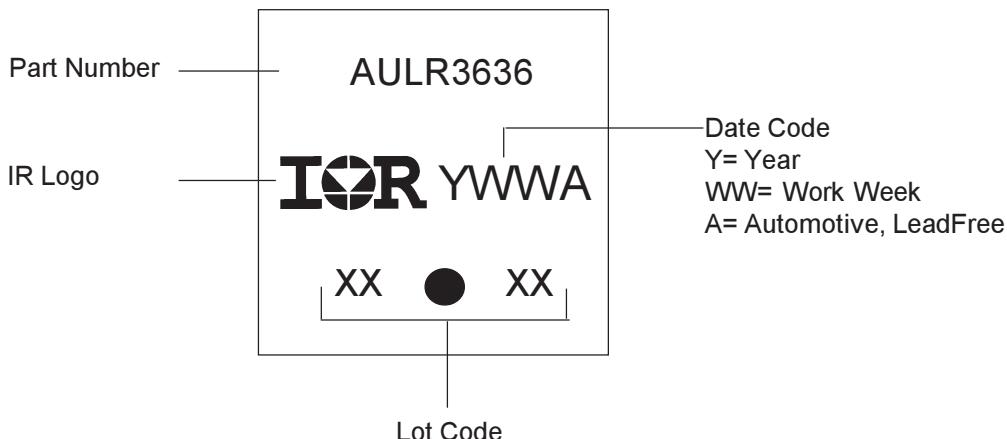
HEXFET

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

IGBT & CoPAK

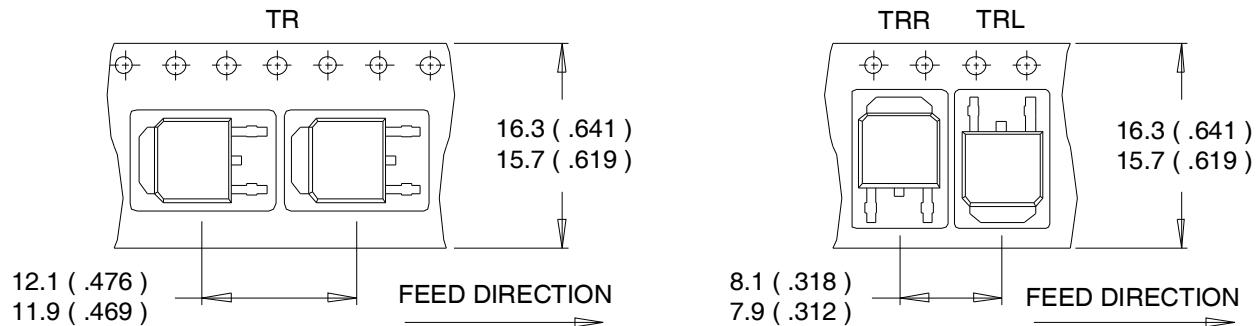
- 1.- GATE
- 2.- COLLECTOR
- 3.- Emitter
- 4.- COLLECTOR

D-Pak (TO-252AA) Part Marking Information



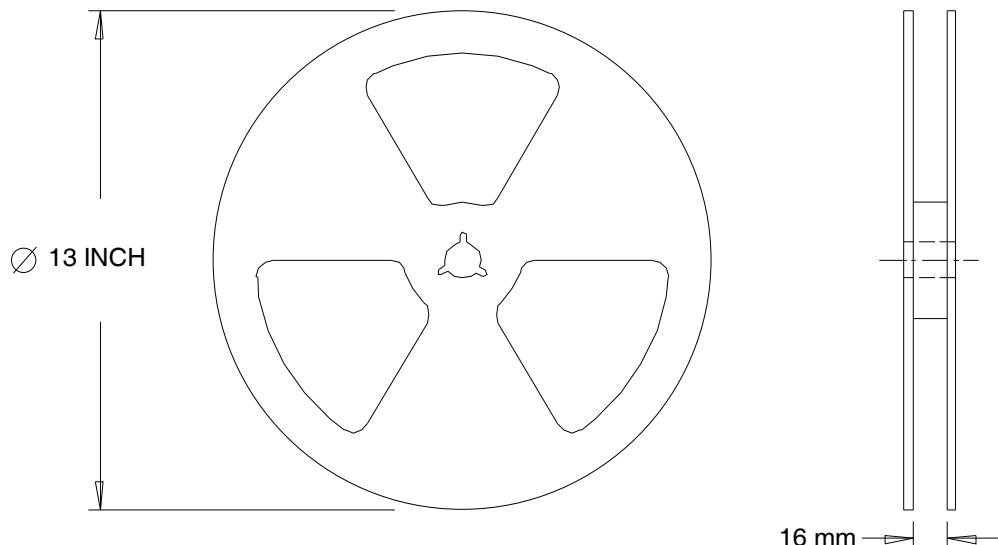
D-Pak (TO-252AA) Tape & Reel Information

Dimensions are shown in millimeters (inches)



NOTES :

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES :

1. OUTLINE CONFORMS TO EIA-481.

Ordering Information

Base part number	Package Type	Standard Pack		Complete Part Number
		Form	Quantity	
AUIRLR3636	Dpak	Tube	75	AUIRLR3636
		Tape and Reel	2000	AUIRLR3636TR
		Tape and Reel Left	3000	AUIRLR3636TRL
		Tape and Reel Right	3000	AUIRLR3636TRR

IMPORTANT NOTICE

Unless specifically designated for the automotive market, International Rectifier Corporation and its subsidiaries (IR) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or services without notice. Part numbers designated with the "AU" prefix follow automotive industry and / or customer specific requirements with regards to product discontinuance and process change notification. All products are sold subject to IR's terms and conditions of sale supplied at the time of order acknowledgment.

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For technical support, please contact IR's Technical Assistance Center

<http://www.irf.com/technical-info/>

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